

MOS FIELD EFFECT TRANSISTOR 2SK3224

SWITCHING N-CHANNEL POWER MOS FET INDUSTRIAL USE

DESCRIPTION

The 2SK3224 is N-Channel MOS Field Effect Transistor designed for high current switching applications.

FEATURES

- Low on-state resistance $R_{DS(on)1} = 40 \text{ m}\Omega \text{ MAX.}$ (VGs = 10 V, ID = 10 A) $R_{DS(on)2} = 60 \text{ m}\Omega \text{ MAX.}$ (VGs = 4.0 V, ID = 10 A)
- Low Ciss : Ciss = 790 pF TYP.
- Built-in gate protection diode
- TO-251/TO-252 package

ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

Drain to Source Voltage (Vgs = 0 V)	Vdss	60	V
Gate to Source Voltage (VDS = 0 V)	VGSS(AC)	±20	V
Gate to Source Voltage ($V_{DS} = 0 V$)	VGSS(DC)	+20, -10	V
Drain Current (DC) (Tc = 25°C)	D(DC)	±20	А
Drain Current (pulse) Note1	D(pulse)	±70	А
Total Power Dissipation (Tc = 25°C)	Ρτ	25	W
Total Power Dissipation (T _A = 25°C)	Рт	1.0	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	–55 to +150	°C
Single Avalanche Current Note2	AS	10	А
Single Avalanche Energy Note2	Eas	10	mJ

PART NUMBER

PART NUMBER	PACKAGE		
2SK3224	TO-251		
2SK3224-Z	TO-252		



(TO-251)

Notes 1. PW \leq 10 μ s, Duty cycle \leq 1%

2. Starting T_{ch} = 25°C, V_{DD} = 30 V, R_G = 25 Ω , V_{GS} = 20 \rightarrow 0 V

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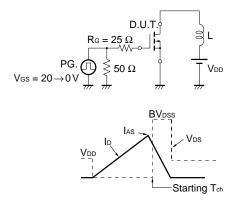
ELECTRICAL CHARACTERISTICS (TA = 25°C)

CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	IDSS	Vds = 60 V, Vgs = 0 V			10	μA
Gate Leakage Current	lgss	$V_{GS} = \pm 20 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			±10	μA
Gate Cut-off Voltage	V _{GS(off)}	V _{DS} = 10 V, I _D = 1 mA	1.0	1.5	2.0	V
Forward Transfer Admittance	y _{fs}	Vds = 10 V, Id = 10 A	8.0	15		S
Drain to Source On-state Resistance	RDS(on)1	$V_{GS} = 10 \text{ V}, \text{ Id} = 10 \text{ A}$		24	40	mΩ
	RDS(on)2	Vgs = 4.0 V, Id = 10 A		33	60	mΩ
Input Capacitance	Ciss	V _{DS} = 10 V		790		pF
Output Capacitance	Coss	Vgs = 0 V		240		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		100		pF
Turn-on Delay Time	td(on)	Vdd = 30 V, Id = 10 A		19		ns
Rise Time	tr	Vgs = 10 V		165		ns
Turn-off Delay Time	td(off)	R _G = 10 Ω		62		ns
Fall Time	tr			71		ns
Total Gate Charge	QG	V _{DD} = 48 V		20		nC
Gate to Source Charge	QGS	Vgs = 10 V		3		nC
Gate to Drain Charge	Qgd	ID = 20 A		6.5		nC
Body Diode Forward Voltage	VF(S-D)	IF = 20 A, VGS = 0 V		0.93		V
Reverse Recovery Time	trr	If = 20 A, V _{GS} = 0 V		40		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/µs		45		nC

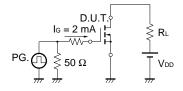
TEST CIRCUIT 1 AVALANCHE CAPABILITY

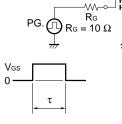
★ TEST CIRCUIT 2 SWITCHING TIME

D.U.T.

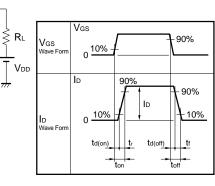


TEST CIRCUIT 3 GATE CHARGE

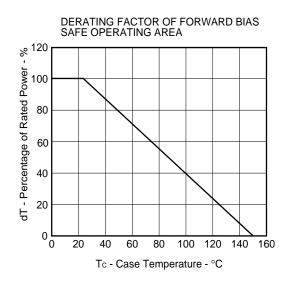




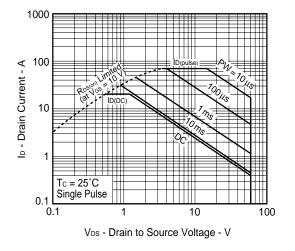
 $\begin{array}{l} \tau = 1 \; \mu s \\ \text{Duty Cycle} \leq 1\% \end{array}$



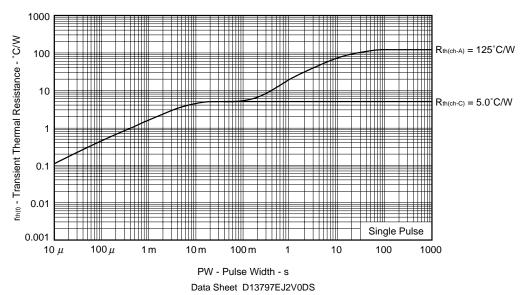
* TYPICAL CHARACTERISTICS (TA = 25°C)



FORWARD BIAS SAFE OPERATING AREA



TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



PT - Total Power Dissipation - W Tc - Case Temperature - °C

TOTAL POWER DISSIPATION vs.

CASE TEMPERATURE

Pulsed

3

4

10

 $V_{DS} = 10 V$ $I_{D} = 1 mA$

Pulsed

DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE

100 100 Ip - Drain Current - A Ip - Drain Current - A 80 $V_{GS} = 10 V$ 10 60 $T_A = -50^{\circ}C$ 40 25°C 75°C Vgs = 4.0 V 1 150°C 20 Pulsed 0.1 **∟** 0 $V_{DS} = 10 V$ 0 2 4 6 8 ō 2 1 VDS - Drain to Source Voltage - V Vgs - Gate to Source Voltage - V DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE FORWARD TRANSFER ADMITTANCE vs. $R_{\text{DS(on)}}$ - Drain to Source On-State Resistance - $m\Omega$ DRAIN CURRENT 100 60 S yrs | - Forward Transfer Admittance 50 10 40 I_D = 10 A T_A = 150 °C 75 °C 25 °C -50 °C 30 1 20 10 $V_{DS} = 10 V$ Pulsed 0. 0 0.1 10 1 100 5 0 ID - Drain Current - A Vgs - Gate to Source Voltage - V DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT GATE TO SOURCE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE $R_{\text{DS(on)}}$ - Drain to Source On-State Resistance - $m\Omega$ Gate to Source Cut-off Voltage - V 80 Pulsed 2.0 70 60 1.5 50 Vgs = 4.0 V 40 1.0 30 Vgs = 10 V 20 0.5 10 VGS(off) -

FORWARD TRANSFER CHARACTERISTICS

0

-50

0

50

Tch - Channel Temperature - °C

100

150

0 L 0.1

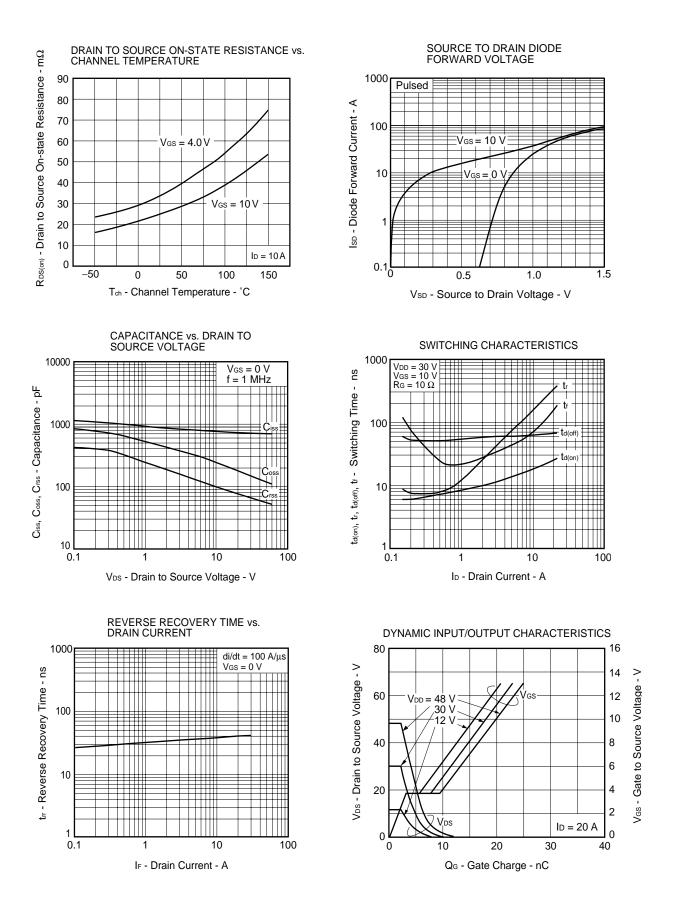
1

ID - Drain Current - A

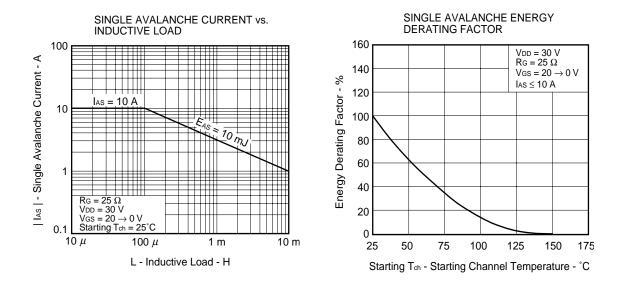
10

100

NEC

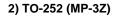


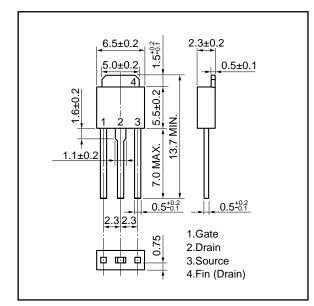
Data Sheet D13797EJ2V0DS

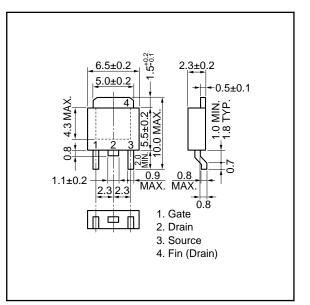


PACKAGE DRAWINGS (Unit: mm)

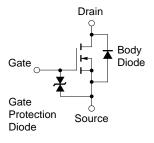
1) TO-251 (MP-3)







EQUIVALENT CIRCUIT



Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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